## FEATURES

Bandwidth: 325 MHz
Low insertion loss and on resistance: $2.6 \Omega$ typical
On resistance flatness: $0.3 \Omega$ typical
Single 3 V/5 V supply operation
3.3 V analog signal range ( 5 V supply, $75 \Omega$ load)

Low quiescent supply current: 1 nA typical
Fast switching times: $\mathrm{t}_{\mathrm{o}}=\mathbf{1 8 6} \mathbf{n s}$, $\mathrm{t}_{\text {off }}=177 \mathrm{~ns}$
$I^{2} \mathrm{C}^{\oplus}$-compatible interface
Compact 24-lead LFCSP
ESD protection
4 kV human body model (HBM)
200 V machine model (MM)
1 kV field-induced charged device model (FICDM)

## APPLICATIONS

S-video RGB/YPbPr video switches
HDTVs
Projection TVs
DVD-R/RW
AV receivers

## GENERAL DESCRIPTION

The ADG791A/ADG791G are monolithic CMOS devices comprising four 2:1 multiplexers/demultiplexers controllable via a standard $\mathrm{I}^{2} \mathrm{C}$ serial interface. The CMOS process provides ultralow power dissipation yet gives high switching speed and low on resistance.

The on-resistance profile is very flat over the full analog input range and wide bandwidth ensures excellent linearity and low distortion. These features, combined with a wide input signal range make the ADG791A/ADG791G the ideal switching solution for a wide range of TV applications including S-video, RGB, and YPbPr video switches.

The switches conduct equally well in both directions when on. In the off condition, signal levels up to the supplies are blocked. The ADG791A/ADG791G switches exhibit break-before-make switching action. The ADG791G has one general-purpose logic output pin controlled by the $\mathrm{I}^{2} \mathrm{C}$ interface that can also be used to control other non- $\mathrm{I}^{2} \mathrm{C}$-compatible devices such as video filters. The integrated $\mathrm{I}^{2} \mathrm{C}$ interface provides a large degree of flexibility in the system design. It has three configurable $\mathrm{I}^{2} \mathrm{C}$ address pins

## Rev. 0

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## ADG791A/ADG791G

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## REVISION HISTORY

## 7/06-Revision 0: Initial Version

## SPECIFICATIONS

$\mathrm{V}_{\mathrm{DD}}=5 \mathrm{~V} \pm 10 \%, \mathrm{GND}=0 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$, unless otherwise noted.
Table 1.

| Parameter | Conditions | Min | Typ ${ }^{1}$ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
| ANALOG SWITCH |  |  |  |  |  |
| Analog Signal Range ${ }^{2}$ | $\mathrm{V}_{S}=\mathrm{V}_{\mathrm{DD}}, \mathrm{R}_{\mathrm{L}}=1 \mathrm{M} \Omega$ | 0 |  | 4 | V |
|  | $\mathrm{V}_{S}=\mathrm{V}_{\mathrm{DD}}, \mathrm{R}_{\mathrm{L}}=75 \Omega$ | 0 |  | 3.3 | V |
| On Resistance, Ron | $V_{D}=0 \mathrm{~V}, \mathrm{l}_{\mathrm{DS}}=-10 \mathrm{~mA}$, see Figure 22 |  | 2.6 | 3.5 | $\Omega$ |
|  | $\mathrm{V}_{\mathrm{D}}=0 \mathrm{~V}$ to $1 \mathrm{~V}, \mathrm{l}_{\mathrm{Ds}}=-10 \mathrm{~mA}$, see Figure 22 |  |  | 4 | $\Omega$ |
| On-Resistance Matching Between Channels, $\Delta$ Ron |  |  |  |  |  |
|  | $\mathrm{V}_{\mathrm{D}}=0 \mathrm{~V}, \mathrm{I}_{\mathrm{DS}}=-10 \mathrm{~mA}$ |  | 0.15 | 0.5 | $\Omega$ |
|  | $\mathrm{V}_{\mathrm{D}}=1 \mathrm{~V}, \mathrm{los}=-10 \mathrm{~mA}$ |  |  | 0.6 | $\Omega$ |
| On-Resistance Flatness, Rflat (on) | $\mathrm{V}_{\mathrm{D}}=0 \mathrm{~V}$ to 1 V , los $=-10 \mathrm{~mA}$ |  | 0.3 | 0.55 | $\Omega$ |
| LEAKAGE CURRENTS |  |  |  |  |  |
| Source OFF Leakage ( $\mathrm{Is}_{\text {( OFF) }}$ ) | $\mathrm{V}_{\mathrm{D}}=4 \mathrm{~V} / 1 \mathrm{~V}, \mathrm{~V}_{\mathrm{S}}=1 \mathrm{~V} / 4 \mathrm{~V}$, see Figure 23 |  | $\pm 0.25$ |  | nA |
| Drain OFF Leakage (lo (OFF)) | $V_{D}=4 \mathrm{~V} / 1 \mathrm{~V}, \mathrm{~V}_{S}=1 \mathrm{~V} / 4 \mathrm{~V}$, see Figure 23 |  | $\pm 0.25$ |  | nA |
| Channel ON Leakage (ID (ON), IS (ON) | $V_{D}=V_{S}=4 \mathrm{~V} / 1 \mathrm{~V}$, see Figure 24 |  | $\pm 0.25$ |  | nA |
| DYNAMIC CHARACTERISTICS ${ }^{3}$ |  |  |  |  |  |
| ton, tenable | $\mathrm{C}_{\mathrm{L}}=35 \mathrm{pF}, \mathrm{R}_{\mathrm{L}}=50 \Omega, \mathrm{~V}_{S}=2 \mathrm{~V}$, see Figure 28 |  | 186 | 250 | ns |
| toff, tilsable | $\mathrm{C}_{\mathrm{L}}=35 \mathrm{pF}, \mathrm{R}_{\mathrm{L}}=50 \Omega, \mathrm{~V}_{S}=2 \mathrm{~V}$, see Figure 28 |  | 177 | 240 | ns |
| Break-Before-Make Time Delay, to | $\mathrm{C}_{\mathrm{L}}=35 \mathrm{pF}, \mathrm{R}_{\mathrm{L}}=50 \Omega, \mathrm{~V}_{\mathrm{s} 1}=\mathrm{V}_{\mathrm{s} 2}=2 \mathrm{~V}$, see Figure 29 | 1 | 3 |  | ns |
| $1^{2} \mathrm{C}$ to GPO Propagation Delay, $\mathrm{t}_{\text {H, }}, \mathrm{t}_{\mathrm{L}}$ | (ADG791G only) |  |  | 130 | ns |
| Off Isolation | $f=10 \mathrm{MHz}, \mathrm{R}_{\mathrm{L}}=50 \Omega$, see Figure 26 |  | -60 |  | dB |
| Channel-to-Channel Crosstalk | $f=10 \mathrm{MHz}, \mathrm{R}_{\mathrm{L}}=50 \Omega$, see Figure 27 |  |  |  |  |
| Same Multiplexer |  |  | -55 |  | dB |
| Different Multiplexer |  |  | -70 |  | dB |
| -3 dB Bandwidth | $\mathrm{R}_{\mathrm{L}}=50 \Omega$, see Figure 25 |  | 325 |  | MHz |
| THD + N | $\mathrm{R}_{\mathrm{L}}=100 \Omega$ |  | 0.14 |  | \% |
| Charge Injection | $\mathrm{C}_{\mathrm{L}}=1 \mathrm{nF}, \mathrm{V}_{\mathrm{S}}=0 \mathrm{~V}$, see Figure 30 |  | 5 |  | pC |
| $\mathrm{C}_{\text {S (off) }}$ |  |  | 10 |  | pF |
| $\mathrm{C}_{\mathrm{D} \text { (0fF) }}$ |  |  | 13 |  | pF |
| $\mathrm{CD}_{\text {( ON) }} \mathrm{Cs}_{\text {(ON) }}$ |  |  | 27 |  | pF |
| Power Supply Rejection Ratio, PSRR | $f=20 \mathrm{kHz}$ |  | 70 |  | dB |
| Differential Gain Error | CCIR330 test signal |  | 0.32 |  | \% |
| Differential Phase Error | CCIR330 test signal |  | 0.44 |  | Degrees |
| LOGIC INPUTS ${ }^{3}$ |  |  |  |  |  |
| A0, A1, A2 |  |  |  |  |  |
| Input High Voltage, $\mathrm{V}_{\text {INH }}$ |  | 2.0 |  |  | V |
| Input Low Voltage, $\mathrm{V}_{\text {INL }}$ |  |  |  | 0.8 | V |
| Input Current, linl or linh | $\mathrm{V}_{\mathrm{IN}}=0 \mathrm{~V}$ to $\mathrm{V}_{\mathrm{DD}}$ |  | 0.005 | $\pm 1$ | $\mu \mathrm{A}$ |
| Input Capacitance, $\mathrm{ClN}_{\text {IN }}$ |  |  | 3 |  | pF |
| SCL, SDA |  |  |  |  |  |
| Input High Voltage, $\mathrm{V}_{\text {INH }}$ |  | $0.7 \times \mathrm{V}_{\mathrm{DD}}$ |  | $V_{D D}+0.3$ | V |
| Input Low Voltage, $\mathrm{V}_{\mathrm{INL}}$ |  | -0.3 |  | $+0.3 \times V_{\text {DD }}$ | V |
| Input Leakage Current, $\mathrm{l}_{\text {IN }}$ | $\mathrm{V}_{\mathrm{IN}}=0 \mathrm{~V}$ to $\mathrm{V}_{\mathrm{DD}}$ |  | 0.005 | $\pm 1$ | $\mu \mathrm{A}$ |
| Input Hysteresis |  |  | $0.05 \times \mathrm{V}_{\text {DD }}$ |  | V |
| Input Capacitance, CIIN |  |  | 3 |  | pF |

## ADG791A/ADG791G

| Parameter | Conditions | Min | Typ ${ }^{1}$ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
| LOGIC OUTPUTS ${ }^{3}$ |  |  |  |  |  |
|  |  |  |  |  |  |
| Output Low Voltage, Vot | $\mathrm{I}_{\text {SINK }}=3 \mathrm{~mA}$ |  |  | 0.4 | V |
|  | $\mathrm{I}_{\text {SINK }}=6 \mathrm{~mA}$ |  |  | 0.6 | V |
| Floating-State Leakage Current |  |  |  | $\pm 1$ | $\mu \mathrm{A}$ |
| Floating-State Output Capacitance |  |  |  | 10 | pF |
| GPO1 Pin and GPO2 Pin |  |  |  |  |  |
| Output Low Voltage, Vol | $\mathrm{I}_{\text {LOAD }}=+2 \mathrm{~mA}$ | 2.0 |  | 0.4 | V |
| Output High Voltage, $\mathrm{V}_{\mathrm{OH}}$ | $\mathrm{l}_{\text {LOAD }}=-2 \mathrm{~mA}$ |  |  |  | V |
| POWER REQUIREMENTS |  |  |  |  |  |
| IdD | Digital inputs $=0 \mathrm{~V}$ or $\mathrm{V}_{\mathrm{DD}}, 1{ }^{1} \mathrm{C}$ interface inactive |  | 0.001 | 1 | $\mu \mathrm{A}$ |
|  | $1^{2} \mathrm{C}$ interface active, $\mathrm{f}_{5 \mathrm{cL}}=400 \mathrm{kHz}$ |  |  | 0.2 | mA |
|  | $1^{2} \mathrm{C}$ interface active, $\mathrm{fscL}^{2}=3.4 \mathrm{MHz}$ |  |  | 0.7 | mA |

[^0]$\mathrm{V}_{\mathrm{DD}}=3 \mathrm{~V} \pm 10 \%, \mathrm{GND}=0 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$, unless otherwise noted.
Table 2.

| Parameter | Conditions | Min | Typ ${ }^{1}$ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
| ANALOG SWITCH |  |  |  |  |  |
| Analog Signal Range ${ }^{2}$ | $\mathrm{V}_{S}=\mathrm{V}_{\mathrm{DD}}, \mathrm{R}_{\mathrm{L}}=1 \mathrm{M} \Omega$ | 0 |  | 2.2 | V |
|  | $V_{S}=V_{D D}, R_{L}=75 \Omega$ | 0 |  | 1.7 | V |
| On Resistance, Ron | $V_{D}=0 \mathrm{~V}, \mathrm{los}=-10 \mathrm{~mA}$, see Figure 22 |  | 3 | 4 | $\Omega$ |
|  | $V_{D}=0 \mathrm{~V}$ to 1 V , los $=-10 \mathrm{~mA}$, see Figure 22 |  |  | 6 | $\Omega$ |
| On-Resistance Matching Between Channels, $\Delta$ Ron |  |  |  |  |  |
|  | $\mathrm{V}_{\mathrm{D}}=0 \mathrm{~V}, \mathrm{los}=-10 \mathrm{~mA}$ |  | 0.15 | 0.6 | $\Omega$ |
|  | $\mathrm{V}_{\mathrm{D}}=1 \mathrm{~V}, \mathrm{los}=-10 \mathrm{~mA}$ |  |  | 1.1 | $\Omega$ |
| On-Resistance Flatness, $\mathrm{R}_{\text {flat (ON) }}$ | $\mathrm{V}_{\mathrm{D}}=0 \mathrm{~V}$ to $1 \mathrm{~V}, \mathrm{los}=-10 \mathrm{~mA}$ |  | 0.8 | 2.8 | $\Omega$ |
| LEAKAGE CURRENTS |  |  |  |  |  |
| Source Off Leakage (Is (off)) | $\mathrm{V}_{\mathrm{D}}=2 \mathrm{~V} / 1 \mathrm{~V}, \mathrm{~V}_{\mathrm{s}}=1 \mathrm{~V} / 2 \mathrm{~V}$, see Figure 23 |  | $\pm 0.25$ |  | nA |
| Drain Off Leakage (ld (off) | $\mathrm{V}_{\mathrm{D}}=2 \mathrm{~V} / 1 \mathrm{~V}, \mathrm{~V}_{\mathrm{S}}=1 \mathrm{~V} / 2 \mathrm{~V}$, see Figure 23 |  | $\pm 0.25$ |  | nA |
| Channel On Leakage (ID (ON), IS (ON) | $V_{D}=V_{s}=2 \mathrm{~V} / 1 \mathrm{~V}$, see Figure 24 |  | $\pm 0.25$ |  | nA |
| DYNAMIC CHARACTERISTICS ${ }^{3}$ |  |  |  |  |  |
| ton, tenable | $\mathrm{C}_{\mathrm{L}}=35 \mathrm{pF}, \mathrm{R}_{\mathrm{L}}=50 \Omega, \mathrm{~V}_{S}=2 \mathrm{~V}$, see Figure 28 |  | 198 | 270 | ns |
| toff, tlisable | $\mathrm{C}_{L}=35 \mathrm{pF}, \mathrm{R}_{\mathrm{L}}=50 \Omega, \mathrm{~V}_{S}=2 \mathrm{~V}$, see Figure 28 |  | 195 | 260 | ns |
| Break-Before-Make Time Delay, to | $\mathrm{C}_{\mathrm{L}}=35 \mathrm{pF}, \mathrm{RL}=50 \Omega, \mathrm{~V}_{\mathrm{S} 1}=\mathrm{V}_{\mathrm{S} 2}=2 \mathrm{~V}$, see Figure 29 | 1 | 3 |  | ns |
| ${ }^{1} \mathrm{C}$ to GPO Propagation Delay, $\mathrm{t}_{\mathrm{t}}, \mathrm{t}_{\mathrm{t}}$ (ADG791G only) |  |  |  | 121 | ns |
| Off Isolation | $f=10 \mathrm{MHz}, \mathrm{R}_{\mathrm{L}}=50 \Omega$, see Figure 26 |  | -60 |  | dB |
| Channel-to-Channel Crosstalk | $f=10 \mathrm{MHz}, \mathrm{R}_{\mathrm{L}}=50 \Omega$, see Figure 27 |  |  |  |  |
| Same Multiplexer |  |  | -55 |  | dB |
| Different Multiplexer |  |  | -70 |  | dB |
| -3 dB Bandwidth | $\mathrm{R}_{\mathrm{L}}=50 \Omega$, see Figure 25 |  | 310 |  | MHz |
| THD + N | $\mathrm{R}_{\mathrm{L}}=100 \Omega$ |  | 0.14 |  | \% |
| Charge Injection | $\mathrm{C}_{\mathrm{L}}=1 \mathrm{nF}, \mathrm{V}_{\mathrm{S}}=0 \mathrm{~V}$, see Figure 30 |  | 2.5 |  | pC |
| $\mathrm{Cs}_{\text {( OFF) }}$ |  |  | 10 |  | pF |
| $\mathrm{C}_{\mathrm{D} \text { (off) }}$ |  |  | 13 |  | pF |
| $\mathrm{C}_{\mathrm{D} \text { (ON), }} \mathrm{CS}_{\text {(ON) }}$ |  |  | 27 |  | pF |
| Power Supply Rejection Ratio, PSRR | $f=20 \mathrm{kHz}$ |  | 70 |  | dB |
| Differential Gain Error | CCIR330 test signal |  | 0.28 |  | \% |
| Differential Phase Error | CCIR330 test signal |  | 0.28 |  | Degrees |
| LOGIC INPUTS ${ }^{3}$ |  |  |  |  |  |
| A0, A1, A2 |  |  |  |  |  |
| Input High Voltage, V ${ }_{\text {INH }}$ |  | 2.0 |  |  | V |
| Input Low Voltage, $\mathrm{V}_{\text {INL }}$ |  |  |  | 0.8 | V |
| Input Current, $\mathrm{l}_{\text {INL }}$ or $\mathrm{l}_{\text {INH }}$ | $\mathrm{V}_{\mathrm{IN}}=0 \mathrm{~V}$ to $\mathrm{V}_{\mathrm{DD}}$ |  | 0.005 | $\pm 1$ | $\mu \mathrm{A}$ |
| Input Capacitance, CIN |  |  | 3 |  | pF |
| SCL, SDA |  |  |  |  |  |
| Input High Voltage, $\mathrm{V}_{\text {INH }}$ |  | $0.7 \times \mathrm{V}_{\text {D }}$ |  | $\mathrm{V}_{\mathrm{DD}}+0.3$ | V |
| Input Low Voltage, $\mathrm{V}_{\text {INL }}$ |  | -0.3 |  | $+0.3 \times \mathrm{V}_{\mathrm{DD}}$ | V |
| Input Leakage Current, lin | $\mathrm{V}_{\mathrm{IN}}=0 \mathrm{~V}$ to $\mathrm{V}_{\mathrm{DD}}$ |  | 0.005 | $\pm 1$ | $\mu \mathrm{A}$ |
| Input Hysteresis |  |  | $0.05 \times \mathrm{V}_{\text {DD }}$ |  | V |
| Input Capacitance, $\mathrm{Cl}_{1 \times}$ |  |  | 3 |  | pF |

## ADG791A/ADG791G

| Parameter | Conditions | Min | Typ ${ }^{1}$ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
| LOGIC OUTPUTS ${ }^{3}$ |  |  |  |  |  |
| SDA Pin |  |  |  |  |  |
| Output Low Voltage, Vol | $\mathrm{I}_{\text {SINK }}=3 \mathrm{~mA}$ |  |  | 0.4 | V |
|  | $\mathrm{I}_{\text {SINK }}=6 \mathrm{~mA}$ |  |  | 0.6 | V |
| Floating-State Leakage Current |  |  |  | $\pm 1$ | $\mu \mathrm{A}$ |
| Floating-State Output Capacitance |  |  | 3 |  | pF |
| GPO1 Pin and GPO2 Pin |  |  |  |  |  |
| Output Low Voltage, Vol | $\mathrm{I}_{\text {LOAD }}=+2 \mathrm{~mA}$ |  |  | 0.4 | V |
| Output High Voltage, $\mathrm{V}_{\mathrm{OH}}$ | $\mathrm{I}_{\text {LOAD }}=-2 \mathrm{~mA}$ | 2.0 |  |  | V |
| POWER REQUIREMENTS |  |  |  |  |  |
| IDD | Digital inputs $=0 \mathrm{~V}$ or $\mathrm{V}_{\mathrm{DD}}, 1{ }^{1} \mathrm{C}$ interface inactive |  | 0.001 | 1 | $\mu \mathrm{A}$ |
|  | $1^{2} \mathrm{C}$ interface active, $\mathrm{f}_{5 \mathrm{cl}}=400 \mathrm{kHz}$ |  |  | 0.1 | mA |
|  | $1^{2} \mathrm{C}$ interface active, $\mathrm{f}_{5 \mathrm{cl}}=3.4 \mathrm{MHz}$ |  |  | 0.2 | mA |

[^1]
## $I^{2} \mathrm{C}$ TIMING SPECIFICATIONS

$\mathrm{V}_{\mathrm{DD}}=2.7 \mathrm{~V}$ to $5.5 \mathrm{~V} ; \mathrm{GND}=0 \mathrm{~V} ; \mathrm{T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$, unless otherwise noted. See Figure 2 for timing diagram.
Table 3.

| Parameter ${ }^{1}$ | Conditions | Min | Max | Unit | Description |
| :---: | :---: | :---: | :---: | :---: | :---: |
| fscl | Standard mode <br> Fast mode <br> High speed mode <br> $\mathrm{C}_{\mathrm{B}}=100 \mathrm{pF}$ max <br> $\mathrm{C}_{\mathrm{B}}=400 \mathrm{pF}$ max |  | $\begin{aligned} & \hline 100 \\ & 400 \\ & \\ & 3.4 \\ & 1.7 \end{aligned}$ | kHz <br> kHz <br> MHz <br> MHz | Serial clock frequency |
| $\mathrm{t}_{1}$ | Standard mode <br> Fast mode <br> High speed mode <br> $\mathrm{C}_{\mathrm{B}}=100 \mathrm{pF}$ max <br> $C_{B}=400 \mathrm{pF}$ max | $\begin{aligned} & \hline 4 \\ & 0.6 \\ & 60 \\ & 120 \\ & \hline \end{aligned}$ |  | $\mu \mathrm{s}$ <br> $\mu s$ <br> ns <br> ns | $\mathrm{t}_{\text {HIGH, }}$ SCL high time |
| $\mathrm{t}_{2}$ | Standard mode <br> Fast mode <br> High speed mode <br> $\mathrm{C}_{\mathrm{B}}=100 \mathrm{pF}$ max <br> $C_{B}=400 \mathrm{pF}$ max | $\begin{aligned} & \hline 4.7 \\ & 1.3 \\ & \\ & 160 \\ & 320 \end{aligned}$ |  | $\mu \mathrm{s}$ <br> $\mu \mathrm{s}$ <br> ns <br> ns | toow, SCL low time |
| $\mathrm{t}_{3}$ | Standard mode <br> Fast mode <br> High speed mode | $\begin{aligned} & \hline 250 \\ & 100 \\ & 10 \\ & \hline \end{aligned}$ |  | $\begin{aligned} & \mathrm{ns} \\ & \mathrm{~ns} \\ & \mathrm{~ns} \end{aligned}$ | $\mathrm{t}_{\text {Su;DAT, }}$ data setup time |
| $\mathrm{t}_{4}{ }^{2}$ | Standard mode <br> Fast mode <br> High speed mode <br> $\mathrm{C}_{\mathrm{B}}=100 \mathrm{pF}$ max <br> $\mathrm{C}_{\mathrm{B}}=400 \mathrm{pF}$ max | $\begin{aligned} & \hline 0 \\ & 0 \\ & 0 \\ & 0 \end{aligned}$ | $\begin{aligned} & \hline 3.45 \\ & 0.9 \\ & 703 \\ & 150 \end{aligned}$ | $\mu \mathrm{s}$ <br> $\mu \mathrm{s}$ <br> ns <br> ns | $\mathrm{t}_{\text {HD;DAT, }}$ data hold time |
| $\mathrm{t}_{5}$ | Standard mode <br> Fast mode <br> High speed mode | $\begin{aligned} & \hline 4.7 \\ & 0.6 \\ & 160 \\ & \hline \end{aligned}$ |  | $\mu \mathrm{s}$ <br> $\mu s$ <br> ns | tsu;TA, setup time for a repeated start condition |
| t6 | Standard mode <br> Fast mode <br> High speed mode | $\begin{aligned} & 4 \\ & 0.6 \\ & 160 \\ & \hline \end{aligned}$ |  | $\begin{aligned} & \mu \mathrm{s} \\ & \mu \mathrm{~s} \\ & \mathrm{~ns} \end{aligned}$ | thi;sta, hold time (repeated) start condition |
| $\mathrm{t}_{7}$ | Standard mode Fast mode | $\begin{aligned} & 4.7 \\ & 1.3 \end{aligned}$ |  | $\begin{aligned} & \mu \mathrm{s} \\ & \mu \mathrm{~s} \end{aligned}$ | $t_{\text {buf, }}$ bus free time between a stop and a start condition |
| $\mathrm{t}_{8}$ | Standard mode <br> Fast mode <br> High speed mode | $\begin{aligned} & \hline 4 \\ & 0.6 \\ & 160 \end{aligned}$ |  | $\mu \mathrm{s}$ <br> $\mu s$ <br> ns | tsu;sto, setup time for stop condition |
| t9 | Standard mode <br> Fast mode <br> High speed mode <br> $\mathrm{C}_{\mathrm{B}}=100 \mathrm{pF}$ max <br> $\mathrm{C}_{\mathrm{B}}=400 \mathrm{pF}$ max | $\begin{aligned} & 20+0.1 C_{B} \\ & 10 \\ & 20 \end{aligned}$ | $\begin{aligned} & 1000 \\ & 300 \\ & \\ & 80 \\ & 160 \end{aligned}$ | ns ns <br> ns <br> ns | $\mathrm{t}_{\text {RDA }}$, rise time of SDA signal |
| $\mathrm{t}_{10}$ | Standard mode <br> Fast mode <br> High speed mode <br> $\mathrm{C}_{\mathrm{B}}=100 \mathrm{pF}$ max <br> $C_{B}=400 \mathrm{pF}$ max | $\begin{aligned} & 20+0.1 C_{B} \\ & 10 \\ & 20 \end{aligned}$ | $\begin{aligned} & \hline 300 \\ & 300 \\ & 80 \\ & 160 \end{aligned}$ | ns <br> ns <br> ns ns | $\mathrm{t}_{\text {FDA }}$, fall time of SDA signal |
| $\mathrm{t}_{11}$ | Standard mode <br> Fast mode <br> High speed mode <br> $\mathrm{C}_{\mathrm{B}}=100 \mathrm{pF}$ max <br> $\mathrm{C}_{\mathrm{B}}=400 \mathrm{pF}$ max | $\begin{aligned} & 20+0.1 C_{B} \\ & 10 \\ & 20 \end{aligned}$ | $\begin{aligned} & 1000 \\ & 300 \\ & 40 \\ & 80 \end{aligned}$ | ns ns <br> ns ns | $\mathrm{t}_{\text {RCL }}$, rise time of SCL signal |

## ADG791A/ADG791G

| Parameter ${ }^{1}$ | Conditions | Min | Max | Unit | Description |
| :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{t}_{11 \mathrm{~A}}$ | Standard mode <br> Fast mode <br> High speed mode $C_{B}=100 \mathrm{pF} \max$ $C_{B}=400 \mathrm{pF} \max$ | $20+0.1 C_{B}$ <br> 10 <br> 20 | $\begin{aligned} & 1000 \\ & 300 \\ & 80 \\ & 160 \\ & \hline \end{aligned}$ | ns <br> ns <br> ns <br> ns | $t_{\text {RCLI }}$, rise time of SCL signal after a repeated start condition and after an acknowledge bit. |
| $\mathrm{t}_{12}$ | Standard mode <br> Fast mode <br> High speed mode <br> $C_{B}=100 \mathrm{pF}$ max <br> $C_{B}=400 \mathrm{pF}$ max | $\begin{aligned} & 20+0.1 C_{B} \\ & 10 \\ & 20 \end{aligned}$ | $\begin{aligned} & \hline 300 \\ & 300 \\ & 40 \\ & 80 \end{aligned}$ | ns <br> ns <br> ns ns | $\mathrm{t}_{\text {FCL }}$, fall time of SCL signal |
| tsp | Fast mode High speed mode | $\begin{aligned} & \hline 0 \\ & 0 \end{aligned}$ | $\begin{aligned} & 50 \\ & 10 \end{aligned}$ | $\begin{aligned} & \mathrm{ns} \\ & \mathrm{~ns} \end{aligned}$ | Pulse width of suppressed spike |

${ }^{1}$ Guaranteed by initial characterization. $C_{B}$ refers to capacitive load on the bus line, $t_{r}$ and $t_{f}$ measured between $0.3 V_{D D}$ and $0.7 V_{D D}$.
${ }^{2}$ A device must provide a data hold time for SDA to bridge the undefined region of the SCL falling edge.

TIMING DIAGRAM


Figure 2. Timing Diagram for 2-Wire Serial Interface

## ADG791A/ADG791G

## ABSOLUTE MAXIMUM RATINGS

$\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$, unless otherwise noted.

Table 4.

| Parameter | Ratings |
| :--- | :--- |
| $V_{\text {DD }}$ to GND | -0.3 V to +6 V |
| Analog, Digital Inputs | -0.3 V to $\mathrm{V}_{\mathrm{DD}}+0.3 \mathrm{~V}$ or |
|  | 30 mA , whichever occurs first |
| Continuous Current, S or D | 100 mA |
| Peak Current, S or D | 300 mA (pulsed at 1 ms, |
|  | $10 \%$ duty cycle max) |
| Operating Temperature Range <br> $\quad$ Industrial (B Version) | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |
| Storage Temperature Range <br> Junction Temperature <br> $\theta_{\text {JA }}$ Thermal Impedance <br> 24-Lead LFCSP | $-65^{\circ} \mathrm{C}$ to $+150^{\circ} \mathrm{C}$ |
| Lead Temperature, Soldering <br> $\quad$ (10 sec) | $150^{\circ} \mathrm{C}$ |
| IR Reflow, Peak Temperature <br> (<20 sec) | $30^{\circ} \mathrm{C} / \mathrm{W}$ |

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Only one absolute maximum rating may be applied at any one time.

## ESD CAUTION

ESD (electrostatic discharge) sensitive device. Electrostatic charges as high as 4000 V readily accumulate on the human body and test equipment and can discharge without detection. Although this product features proprietary ESD protection circuitry, permanent damage may occur on devices subjected to high energy electrostatic discharges. Therefore, proper ESD precautions are recommended to avoid performance degradation or loss of functionality.

## ADG791A/ADG791G

## PIN CONFIGURATIONS AND FUNCTION DESCRIPTIONS



Figure 3. ADG791G Pin Configuration

| NOTES | Ot |
| :--- | ---: |
| 1. NC = NO CONNECT. | ò |
| 2. THE EXPOSED PAD MUST BE TIED TO GND. |  |
| 0 |  |




1. NC = NO CONNECT.
2. THE EXPOSED PAD MUST BE TIED TO GND.

Figure 4. ADG791A Pin Configuration

Table 5. ADG791A/ADG791G Pin Function Descriptions

| Pin No. | Mnemonic | Description |
| :--- | :--- | :--- |
| 1 | S1A | A-Side Source Terminal for Mux 1. Can be an input or output. |
| 2 | S1B | B-Side Source Terminal for Mux 1. Can be an input or output. |
| 3 | D1 | Drain Terminal for Mux 1. Can be an input or output. |
| 4 | D2 | Drain Terminal for Mux 2. Can be an input or output. |
| 5 | S2B | B-Side Source Terminal for Mux 2. Can be an input or output. |
| 6 | S2A | A-Side Source Terminal for Mux 2. Can be an input or output. |
| 7 | S3A | A-Side Source Terminal for Mux 3. Can be an input or output. |
| 8 | S3B | B-Side Source Terminal for Mux 3. Can be an input or output. |
| 9 | D3 | Drain Terminal for Mux 3. Can be an input or output. |
| 10 | D4 | Drain Terminal for Mux 4. Can be an input or output. |
| 11 | S4B | B-Side Source Terminal for Mux 4. Can be an input or output. |
| 12 | S4A | A-Side Source Terminal for Mux 4. Can be an input or output. |
| 13 | NC | Not Internally Connected. |
| 14 | NC | Not Internally Connected. |
| 15 | NC | Not Internally Connected. |
| 16 | NC/GPO1 | Not Internally Connected for ADG791A/General-Purpose Logic Output 1 for ADG791G. |
| 17 | NC | Not Internally Connected. |
| 18 | A2 | Logic Input. Sets Bit A2 from the least significant bit of the 7-bit slave address. |
| 19 | A1 | Logic Input. Sets Bit A1 from the least significant bit of the 7-bit slave address. |
| 20 | A0 | Logic Input. Sets Bit A0 from the least significant bit of the 7-bit slave address. |
| 21 | SCL | Digital Input, Serial Clock Line. Open-drain input that is used in conjunction with SDA to clock data into |
| 22 | the device. External pull-up resistor required. |  |
| 23 | Digital l/O. Bidirectional, open-drain data line. External pull-up resistor required. |  |
| 24 | Positive Power Supply Input. |  |

## TYPICAL PERFORMANCE CHARACTERISTICS



Figure 5. Analog Signal Range, 3 V Supply


Figure 6. Analog Signal Range, 5 V Supply


Figure 7. On Resistance vs. $V_{D}\left(V_{s}\right), 3 V$ Supply


Figure 8. On Resistance vs. $V_{D}\left(V_{s}\right), 5$ V Supply


Figure 9. On Resistance vs. $V_{D}\left(V_{s}\right)$ for Various Temperatures, 3 V Supply


Figure 10. On Resistance vs. $V_{D}\left(V_{S}\right)$ for Various Temperatures, 5 V Supply

## ADG791A/ADG791G



Figure 11. Charge Injection vs. Source Voltage


Figure 12. $t_{o n} / t_{\text {off }}$ vs. Temperature


Figure 13. Off Isolation vs. Frequency


Figure 14. Crosstalk vs. Frequency


Figure 15. Bandwidth


Figure 16. PSRR vs. Frequency


Figure 17. IDD vs. fCLK Frequency


Figure 18. $I_{D D}$ vs. $I^{2}$ C Logic Input Voltage (SDA, SCL)


Figure 19. $1^{2}$ C to GPO Propagation Delay vs. Temperature (ADG791G Only)


Figure 20. GPO VOH vs. Load Current


Figure 21. GPO Vol vs. Load Current

## ADG791A/ADG791G

## TEST CIRCUITS



Figure 22. On Resistance


Figure 23. Off Leakage


Figure 24. On Leakage


Figure 25. Bandwidth


Figure 26. Off Isolation


Figure 27. Channel-to-Channel Crosstalk


Figure 28. Switching Time


Figure 30. Charge Injection

## ADG791A/ADG791G

## TERMINOLOGY

## On Resistance (Ron)

The series on-channel resistance measured between the $S$ and D pins.

On Resistance Match ( $\Delta$ Ros)
The channel-to-channel matching of on resistance when channels are operated under identical conditions.

On Resistance Flatness ( Relation) )
The variation of on resistance over the specified range produced by the specified analog input voltage change with a constant load current.

## Channel Off Leakage (Ioff)

The sum of leakage currents into or out of an off channel input.

## Channel On Leakage ( $\mathrm{I}_{\mathrm{on}}$ )

The current loss/gain through an on-channel resistance, creating a voltage offset across the device.

Input Leakage Current ( $\mathbf{I}_{\text {IN }}, \mathbf{I}_{\text {INL }}, \mathbf{I}_{\text {INH }}$ )
The current flowing into a digital input when a specified low level or high level voltage is applied to that input.

## Input/Output Off Capacitance (Coff)

The capacitance between an analog input and ground when the switch channel is off.

## Input/Output On Capacitance (Con)

The capacitance between the inputs or outputs and ground when the switch channel is on.

Digital Input Capacitance ( $\mathrm{C}_{\mathrm{IN}}$ )
The capacitance between a digital input and ground.

## Output On Switching Time (ton)

The time required for the switch channel to close. The time is measured from $50 \%$ of the falling edge of the LDSW bit to the time the output reaches $90 \%$ of the final value.

Output Off Switching Time (toff)
The time required for the switch to open. The time is measured from $50 \%$ of the falling edge of the LDSW bit to the time the output reaches $10 \%$ of the final value.
$I^{2} \mathrm{C}$ to GPO Propagation Delay ( $\mathrm{t}_{\mathrm{H}}, \mathrm{t}_{\mathrm{L}}$ )
The time required for the logic value at the GPO pin to settle after loading a GPO command. The time is measured from $50 \%$ of the falling edge of the LDSW bit to the time the output reaches $90 \%$ of the final value for high and $10 \%$ for low.

## Total Harmonic Distortion + Noise (THD + N)

The ratio of the harmonic amplitudes plus noise of a signal to the fundamental.

## -3 dB Bandwidth

The frequency at which the output is attenuated by 3 dB .

## Off Isolation

The measure of unwanted signal coupling through an off switch.

## Crosstalk

The measure of unwanted signal that is coupled through from one channel to another as a result of parasitic capacitance.

## Charge Injection

The measure of the glitch impulse transferred from the digital input to the analog output during on/off switching.

## Differential Gain Error

The measure of how much color saturation shift occurs when the luminance level changes. Both attenuation and amplification can occur; therefore, the largest amplitude change between any two levels is specified and expressed in \%.

## Differential Phase Error

The measure of how much hue shift occurs when the luminance level changes. It can be a negative or positive value and is expressed in degrees of subcarrier phase.

## Input High Voltage ( $\mathrm{V}_{\mathrm{INH}}$ )

The minimum input voltage for Logic 1.
Input Low Voltage ( $\mathrm{V}_{\mathrm{INL}}$ )
The maximum input voltage for Logic 0 .
Output High Voltage ( $\mathrm{V}_{\mathrm{OH}}$ )
The minimum output voltage for Logic 1.
Output Low Voltage ( $\mathrm{V}_{\mathrm{oL}}$ )
The maximum output voltage for Logic 0 .

## $\mathrm{I}_{\mathrm{DD}}$

Positive supply current.

## THEORY OF OPERATION

The ADG791A/ADG791G are monolithic CMOS devices comprising four 2:1 multiplexers controllable via a standard $\mathrm{I}^{2} \mathrm{C}$ serial interface. The CMOS process provides ultralow power dissipation, yet offers high switching speed and low on resistance.

The on resistance profile is very flat over the full analog input range, and wide bandwidth ensures excellent linearity and low distortion. These features, combined with a wide input signal range, make the ADG791A/ADG791G an ideal switching solution for a wide range of TV applications.

The switches conduct equally well in both directions when on. In the off condition, signal levels up to the supplies are blocked. The integrated serial $I^{2} \mathrm{C}$ interface controls the operation of the switches (ADG791A/ADG791G) and general-purpose logic pins (ADG791G only).
The ADG791A/ADG791G have many attractive features, such as the ability to individually control each multiplexer, the option of reading back the status of any switch. The ADG791G has one general-purpose logic output pin controllable through the $I^{2} \mathrm{C}$ interface. The following sections describe these features in detail.

## $I^{2} \mathbf{C}$ SERIAL INTERFACE

The ADG791A/ADG791G are controlled via an $\mathrm{I}^{2} \mathrm{C}$-compatible serial bus interface (refer to the $I^{2} C$-Bus Specification available from Philips Semiconductor) that allows the part to operate as a slave device (no clock is generated by the ADG791A/ADG791G). The communication protocol between the $\mathrm{I}^{2} \mathrm{C}$ master and the device operates as follows:

1. The master initiates data transfer by establishing a start condition (defined as a high-to-low transition on the SDA line while SCL is high). This indicates that an address/data stream follows. All slave devices connected to the bus respond to the start condition and shift in the next eight bits, consisting of a 7-bit address (MSB first) plus an R/W bit. This bit determines the direction of the data flow during the communication between the master and the addressed slave device.
2. The slave device whose address corresponds to the transmitted address responds by pulling the SDA line low during the ninth clock pulse (this is known as the acknowledge bit).

At this stage, all other devices on the bus remain idle while the selected device waits for data to be written to, or read from, its serial register. If the $\mathrm{R} / \overline{\mathrm{W}}$ bit is set high, the master reads from the slave device. However, if the $\mathrm{R} / \overline{\mathrm{W}}$ bit is set low, the master writes to the slave device.
3. Data transmits over the serial bus in sequences of nine clock pulses (eight data bits followed by an acknowledge bit). The transitions on the SDA line must occur during the low period of the clock signal, SCL, and remain stable during the high period of SCL. Otherwise, a low-to-high transition when the clock signal is high can be interpreted as a stop event that ends the communication between the master and the addressed slave device.
4. After transferring all data bytes, the master establishes a stop condition, defined as a low-to-high transition on the SDA line while SCL is high. In write mode, the master pulls the SDA line high during the $10^{\text {th }}$ clock pulse to establish a stop condition. In read mode, the master issues a no acknowledge for the ninth clock pulse (the SDA line remains high). The master then brings the SDA line low before the $10^{\text {th }}$ clock pulse, and then high during the $10^{\text {th }}$ clock pulse to establish a stop condition.

## $I^{2}$ C ADDRESS

The ADG791A/ADG791G has a 7-bit I ${ }^{2} \mathrm{C}$ address. The four most significant bits are internally hardwired while the last three bits (A0, A1, and A2) are user-adjustable. This allows the user to connect up to eight ADG791As/ADG791Gs to the same bus. The $\mathrm{I}^{2} \mathrm{C}$ bit map shows the configuration of the address.

## 7-Bit $I^{2}$ C Address Configuration

MSB

|  | LSB |  |  |  |  |  |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- |
| 1 | 0 | 1 | 0 | A2 | A1 | A0 |

## WRITE OPERATION

When writing to the ADG791A/ADG791G, the user must begin with an address byte and $\mathrm{R} / \overline{\mathrm{W}}$ bit, after which time the switch acknowledges that it is prepared to receive data by pulling SDA low. Data is loaded into the device as a 16 -bit word under the control of a serial clock input, SCL. Figure 31 illustrates the entire write sequence for the ADG791A/ ADG791G. The first data byte (AX7 to AX0) controls the status of the switches while the LDSW and RESETB bits from the second byte control the operation mode of the device.

Table 6 shows a list of all commands supported by the ADG791A/ADG791G with the corresponding byte that needs to be loaded during a write operation.
To achieve the desired configuration, one or more commands can be loaded into the device. Any combination of the commands listed in Table 6 can be used with these restrictions:

- Only one switch from a given multiplexer can be ON at any given time
- When a sequence of successive commands affect the same element (that is, the switch or GPO pin), only the last command is executed.


## ADG791A/ADG791G



Figure 31. Write Operation

Table 6. ADG791A/ADG791G Command List

| AX7 | AX6 | AX5 | AX4 | AX3 | AX2 | AX1 | AX0 | Addressed Switch |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- |
| 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | S1A/D1, S2A/D2, S3A/D3, S4A/D4 off |
| 1 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | S1A/D1, S2A/D2, S3A/D3, S4A/D4 on |
| 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | S1B/D1, S2B/D2, S3B/D3, S4B/D4 off |
| 1 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | S1B/D1, S2B/D2, S3B/D3, S4B/D4 on |
| 0 | 0 | 0 | 0 | 0 | 0 | 1 | 0 | S1A/D1 off |
| 1 | 0 | 0 | 0 | 0 | 0 | 1 | 0 | S1A/D1 on |
| 0 | 0 | 0 | 0 | 0 | 0 | 1 | 1 | S1B/D1 off |
| 1 | 0 | 0 | 0 | 0 | 0 | 1 | 1 | S1B/D1 on |
| 0 | 0 | 0 | 0 | 0 | 1 | 0 | 0 | S2A/D2 off |
| 1 | 0 | 0 | 0 | 0 | 1 | 0 | 0 | S2A/D2 on |
| 0 | 0 | 0 | 0 | 0 | 1 | 0 | 1 | S2B/D2 off |
| 1 | 0 | 0 | 0 | 0 | 1 | 0 | 1 | S2B/D2 on |
| 0 | 0 | 0 | 0 | 0 | 1 | 1 | 0 | S3A/D3 off |
| 1 | 0 | 0 | 0 | 0 | 1 | 1 | 0 | S3A/D3 on |
| 0 | 0 | 0 | 0 | 0 | 1 | 1 | 1 | S3B/D3 off |
| 1 | 0 | 0 | 0 | 0 | 1 | 1 | 1 | S3B/D3 on |
| 0 | 0 | 0 | 0 | 1 | 0 | 0 | 0 | S4A/D4 off |
| 1 | 0 | 0 | 0 | 1 | 0 | 0 | 0 | S4A/D4 on |
| 0 | 0 | 0 | 0 | 1 | 0 | 0 | 1 | S4B/D4 off |
| 1 | 0 | 0 | 0 | 1 | 0 | 0 | 1 | S4B/D4 on |
| $X^{1}$ | 0 | 0 | 0 | 1 | 0 | 1 | 0 | Reserved |
| $X^{1}$ | 0 | 0 | 0 | 1 | 0 | 1 | 1 | Reserved |
| $X^{1}$ | 0 | 0 | 0 | 1 | 1 | 0 | 0 | Reserved |
| $X^{1}$ | 0 | 0 | 0 | 1 | 1 | 0 | 1 | Reserved |
| $X^{1}$ | 0 | 0 | 0 | 1 | 1 | 1 | 0 | Mux 1 disabled (all switches connected to D1 are off) |
| $X^{1}$ | 0 | 0 | 0 | 1 | 1 | 1 | 1 | Mux 2 disabled (all switches connected to D2 are off) |
| $X^{1}$ | 0 | 0 | 1 | 0 | 0 | 0 | 0 | Mux 3 disabled (all switches connected to D3 are off) |
| $X^{1}$ | 0 | 0 | 1 | 0 | 0 | 0 | 1 | Mux 4 disabled (all switches connected to D4 are off) |
| $X^{1}$ | 0 | 0 | 1 | 0 | 0 | 1 | 0 | Reserved |
| $X^{1}$ | 0 | 0 | 1 | 0 | 0 | 1 | 1 | Reserved |
| 1 | 0 | 0 | 1 | 0 | 1 | 0 | 0 | GPO1 high for ADG791G/reserved for ADG791A |
| 0 | 0 | 0 | 1 | 0 | 1 | 0 | 0 | GPO1 low for ADG791G/reserved for ADG791A |
| 0 | 0 | 0 | 1 | 1 | 1 | 1 | 1 | All muxes disabled |
| 1 | 0 | 0 | 1 | 1 | 1 | 1 | 1 | Reserved |
|  |  |  |  |  |  | 1 |  |  |

[^2]
## ADG791A/ADG791G

## LDSW BIT

The LDSW bit allows the user to control the way the device executes the commands loaded during the write operations. The ADG791A/ADG791G executes all the commands loaded between two successive write operations that have set the LDSW bit high.

Setting the LDSW high for every write cycle ensures that the device executes the command right after the LDSW bit was loaded into the device. This setting can be used when the desired configuration can be achieved by sending a single command or when the switches and/or GPO pin are not required to be updated at the same time. When the desired configuration requires multiple commands with simultaneous update, the LDSW bit should be set low while loading the commands except the last one when the LDSW bit should be set high. Once the last command with LDSW = high is loaded, the device executes all commands received since the last update simultaneously.

## POWER ON/SOFTWARE RESET

The ADG791A/ADG791G has a software reset function implemented by the RESETB bit from the second data byte written to the device. For normal operation of the multiplexers and GPO pin, this bit should be set high. When RESETB = low or after power-up, the switches from all multiplexers are turned off (open) and the GPO pin is set low.

## READ OPERATION

When reading data back from the ADG791A/ADG791G, the user must begin with an address byte and $\mathrm{R} / \overline{\mathrm{W}}$ bit. The switch then acknowledges that it is prepared to transmit data by pulling SDA low. Following this acknowledgement, the ADG791A/ADG791G transmits two bytes on the next clock edges. These bytes contain the status of the switches, and each byte is followed by an acknowledge bit. A logic high bit represents a switch in the on (close) state while a low represents a switch in the off (open) state. For the GPO pin (ADG791G only), the bit represents the logic value of the pin. Figure 32 illustrates the entire read sequence.

The bit maps accompanying Figure 32 show the relationship between the elements of the ADG791A and ADG791G (that it, the switches and GPO pins) and the bits that represent their status after a completed read operation.

| RB15 | RB14 | RB13 | RB12 | RB11 | RB10 | RB9 | RB8 | RB7 | RB6 | RB5 | RB4 | RB3 | RB2 | RB1 | RB0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| S1A/D1 | S1B/D1 | S2A/D2 | S2B/D2 | S3A/D3 | S3B/D3 | S4A/D4 | S4B/D4 | - | - | - | - | - | - | - | - |

ADG791G Bit Map

| RB15 | RB14 | RB13 | RB12 | RB11 | RB10 | RB9 | RB8 | RB7 | RB6 | RB5 | RB4 | RB3 | RB2 | RB1 | RB0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| S1A/D1 | S1B/D1 | S2A/D2 | S2B/D2 | S3A/D3 | S3B/D3 | S4A/D4 | S4B/D4 | - | - | - | - | GPO1 | - | - | - |



Figure 32. ADG791A/ADG791G Read Operation

## ADG791A/ADG791G

## EVALUATION BOARD

The ADG791G evaluation kit allows designers to evaluate the high performance of the device with a minimum of effort.

The evaluation kit includes a printed circuit board populated with the ADG791G. The evaluation board can be used to evaluate the performance of both the ADG791A and ADG791G. It interfaces to the USB port of a PC, or it can be used as a standalone evaluation board. Software is available with the evaluation board that allows the user to easily program the ADG791G through the USB port. Schematics of the evaluation board are shown in Figure 33 and Figure 34. The software runs on any PC that has Microsoft ${ }^{\star}$ Windows ${ }^{\star} 2000$ or Windows XP installed.

## USING THE ADG791G EVALUATION BOARD

The ADG791G evaluation kit is a test system designed to simplify the evaluation of the device. Each input/output of the part comes with a socket specifically chosen for easy audio/video evaluation. A data sheet is also available and gives full information on operating the evaluation board.


Figure 33. EVAL-ADG791GEB Schematic, USB Controller Section

## ADG791A/ADG791G



Figure 34. EVAL-ADG791GEB Schematic, Chip Section

## OUTLINE DIMENSIONS



Figure 35. 24-Lead Lead Frame Chip Scale Package [LFCSP_VQ]
4 mm x 4 mm Body, Very Thin Quad (CP-24-2)
Dimensions shown in millimeters

## ORDERING GUIDE

| Model | Temperature Range | $1^{2} \mathrm{C}$ Speed | Package Description | Package Option |
| :---: | :---: | :---: | :---: | :---: |
| ADG791ABCPZ-REEL ${ }^{1}$ | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | $100 \mathrm{kHz}, 400 \mathrm{kHz}$ | 24-Lead LFCSP_VQ | CP-24-2 |
| ADG791ABCPZ-500RL71 | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | $100 \mathrm{kHz}, 400 \mathrm{kHz}$ | 24-Lead LFCSP_VQ | CP-24-2 |
| ADG791ACCPZ-REEL ${ }^{1}$ | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | $100 \mathrm{kHz}, 400 \mathrm{kHz}, 3.4 \mathrm{MHz}$ | 24-Lead LFCSP_VQ | CP-24-2 |
| ADG791ACCPZ-500RL71 | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | $100 \mathrm{kHz}, 400 \mathrm{kHz}, 3.4 \mathrm{MHz}$ | 24-Lead LFCSP_VQ | CP-24-2 |
| ADG791GBCPZ-REEL ${ }^{1}$ | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | $100 \mathrm{kHz}, 400 \mathrm{kHz}$ | 24-Lead LFCSP_VQ | CP-24-2 |
| ADG791GBCPZ-500RL71 | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | $100 \mathrm{kHz}, 400 \mathrm{kHz}$ | 24-Lead LFCSP_VQ | CP-24-2 |
| ADG791GCCPZ-REEL ${ }^{1}$ | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | $100 \mathrm{kHz}, 400 \mathrm{kHz}, 3.4 \mathrm{MHz}$ | 24-Lead LFCSP_VQ | CP-24-2 |
| ADG791GCCPZ-500RL71 | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | $100 \mathrm{kHz}, 400 \mathrm{kHz}, 3.4 \mathrm{MHz}$ | 24-Lead LFCSP_VQ | CP-24-2 |
| EVAL-ADG791GEB ${ }^{2}$ |  |  | Evaluation Board |  |

${ }^{1} \mathrm{Z}=\mathrm{Pb}$-free part.
${ }^{2}$ Evaluation board is RoHS compliant.

## ADG791A/ADG791G

## NOTES

 Rights to use these components in an $I^{2} C$ system, provided that the system conforms to the $I^{2} C$ Standard Specification as defined by Philips.
[^0]:    ${ }^{1} \mathrm{All}$ typical values are at $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$, unless otherwise stated.
    ${ }^{2}$ Guaranteed by initial characterization, not subject to production test.
    ${ }^{3}$ Guaranteed by design, not subject to production test.

[^1]:    ${ }^{1} \mathrm{All}$ typical values are at $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$, unless otherwise stated.
    ${ }^{2}$ Guaranteed by initial characterization, not subject to production test.
    ${ }^{3}$ Guaranteed by design, not subject to production test.

[^2]:    ${ }^{1} \mathrm{X}=$ Logic state does not matter.

